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IGBT

TRENCHSTOP™ IGBT4 Low Power Chip  
IGC99T120T8RL

Data Sheet

Industrial Power Control



## Table of Contents

|   |   |
|---|---|
| Features and Applications.....              | 3 |
| Mechanical Parameters.....                  | 3 |
| Maximum Ratings.....                        | 4 |
| Static and Electrical Characteristics ..... | 4 |
| Further Electrical Characteristics .....    | 5 |
| Chip Drawing.....                           | 6 |
| Revision History .....                      | 7 |
| Relevant Application Notes .....            | 7 |
| Legal Disclaimer .....                      | 8 |

## TRENCHSTOP™ IGBT4 Low Power Chip

### Features:

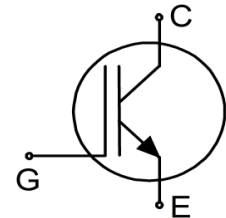
- 1200V trench & field stop technology
- Low switching losses
- Positive temperature coefficient
- Easy paralleling

### Recommended for:

- Low / medium power modules

### Applications:

- Low / medium power drives



| Chip Type     | $V_{CE}$ | $I_{Cn}^1$ | Die Size        | Package      |
|---------------|----------|------------|-----------------|--------------|
| IGC99T120T8RL | 1200V    | 100A       | 9.5mm x 10.39mm | Sawn on foil |

### Mechanical Parameters

|                                  |   |  |
|----------------------------------|---|--|
| Die size                         | 9.5 x 10.35   | mm <sup>2</sup>  |
| Emitter pad size                 | See chip drawing  |  |
| Gate pad size                    | 1.31 x 0.811  |  |
| Area total                       | 98.71   |  |
| Thickness                        | 115   | μm   |
| Wafer size                       | 200   | mm   |
| Maximum possible chips per wafer | 258   |  |
| Passivation frontside            | Photoimide  |  |
| Pad metal                        | 3200nm AlSiCu   |  |
| Backside metal                   | Ni Ag – system<br>To achieve a reliable solder connection it is strongly recommended not to consume the Ni layer completely during production process |  |
| Die bond                         | Electrically conductive epoxy glue and soft solder  |  |
| Wire bond                        | Al, ≤500μm  |  |
| Reject ink dot size              | ∅ 0.65mm; max. 1.2mm  |  |
| Storage environment              | for original and sealed MBB bags  | Ambient atmosphere air, temperature 17°C – 25°C, <6 months   |
|                                  | for open MBB bags   | Acc. to IEC62258-3: atmosphere >99% Nitrogen or inert gas, humidity <25%RH, temperature 17°C – 25°C, <6 months |

<sup>1</sup> Nominal collector current at  $T_C=100^\circ\text{C}$  for chip packaged in power modules, see application example cited on page 5.

## Maximum Ratings

| Parameter   | Symbol       | Value        | Unit               |
|---|--------------|--------------|--------------------|
| Collector-emitter voltage, $T_{vj}=25^{\circ}\text{C}$  | $V_{CE}$     | 1200         | V                  |
| DC collector current, limited by $T_{vj\text{ max}}^2$  | $I_C$        | -            | A                  |
| Pulsed collector current, $t_p$ limited by $T_{vj\text{ max}}^3$  | $I_{C,puls}$ | 300          | A                  |
| Gate-emitter voltage  | $V_{GE}$     | $\pm 20$     | V                  |
| Operating junction temperature  | $T_{vj}$     | -40 ... +175 | $^{\circ}\text{C}$ |
| Short circuit data <sup>3/4</sup> $V_{GE}=15\text{V}$ , $V_{CC}=800\text{V}$ , $T_{vj}=150^{\circ}\text{C}$ | $t_{sc}$     | 10           | $\mu\text{s}$      |

## Static Characteristics (tested on wafer), $T_{vj}=25^{\circ}\text{C}$

| Parameter                            | Symbol        | Conditions                                 | Value |      |      | Unit          |
|--------------------------------------|---------------|--|-------|------|------|---------------|
|                                      |               |  | min.  | typ. | max. |               |
| Collector-emitter breakdown voltage  | $V_{(BR)CES}$ | $V_{GE}=0\text{V}$ , $I_C=3.8\text{mA}$    | 1200  | -    | -    | V             |
| Collector-emitter saturation voltage | $V_{CEsat}$   | $V_{GE}=15\text{V}$ , $I_C=100\text{A}$    | 1.53  | 1.75 | 1.97 |               |
| Gate-emitter threshold voltage       | $V_{GE(th)}$  | $I_C=3.8\text{mA}$ , $V_{GE}=V_{CE}$       | 5.1   | 5.8  | 6.4  |               |
| Zero gate voltage collector current  | $I_{CES}$     | $V_{CE}=1200\text{V}$ , $V_{GE}=0\text{V}$ | -     | -    | 1.3  | $\mu\text{A}$ |
| Gate-emitter leakage current         | $I_{GES}$     | $V_{CE}=0\text{V}$ , $V_{GE}=20\text{V}$   | -     | -    | 120  | nA            |
| Integrated gate resistor             | $r_G$         |  | 7.5   |      |      | $\Omega$      |

## Electrical Characteristics <sup>3</sup>

| Parameter                            | Symbol      | Conditions   | Value |      |      | Unit |
|--------------------------------------|-------------|--|-------|------|------|------|
|                                      |             |  | min.  | typ. | max. |      |
| Collector-emitter saturation voltage | $V_{CEsat}$ | $V_{GE}=15\text{V}$ , $I_C=100\text{A}$ ,<br>$T_{vj}=150^{\circ}\text{C}$                      | -     | 2.1  | -    | V    |
| Input capacitance                    | $C_{ies}$   | $V_{CE}=25\text{V}$ ,<br>$V_{GE}=0\text{V}$ , $f=1\text{MHz}$ ,<br>$T_{vj}=25^{\circ}\text{C}$ | -     | 6300 | -    | pF   |
| Reverse transfer capacitance         | $C_{res}$   |  | -     | 270  | -    |      |

<sup>2</sup> Depending on thermal properties of assembly.

<sup>3</sup> Not subject to production test - verified by design/characterization.

<sup>4</sup> Allowed number of short circuits: <1000; time between short circuits: >1s.



# IGC99T120T8RL

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## Further Electrical Characteristics

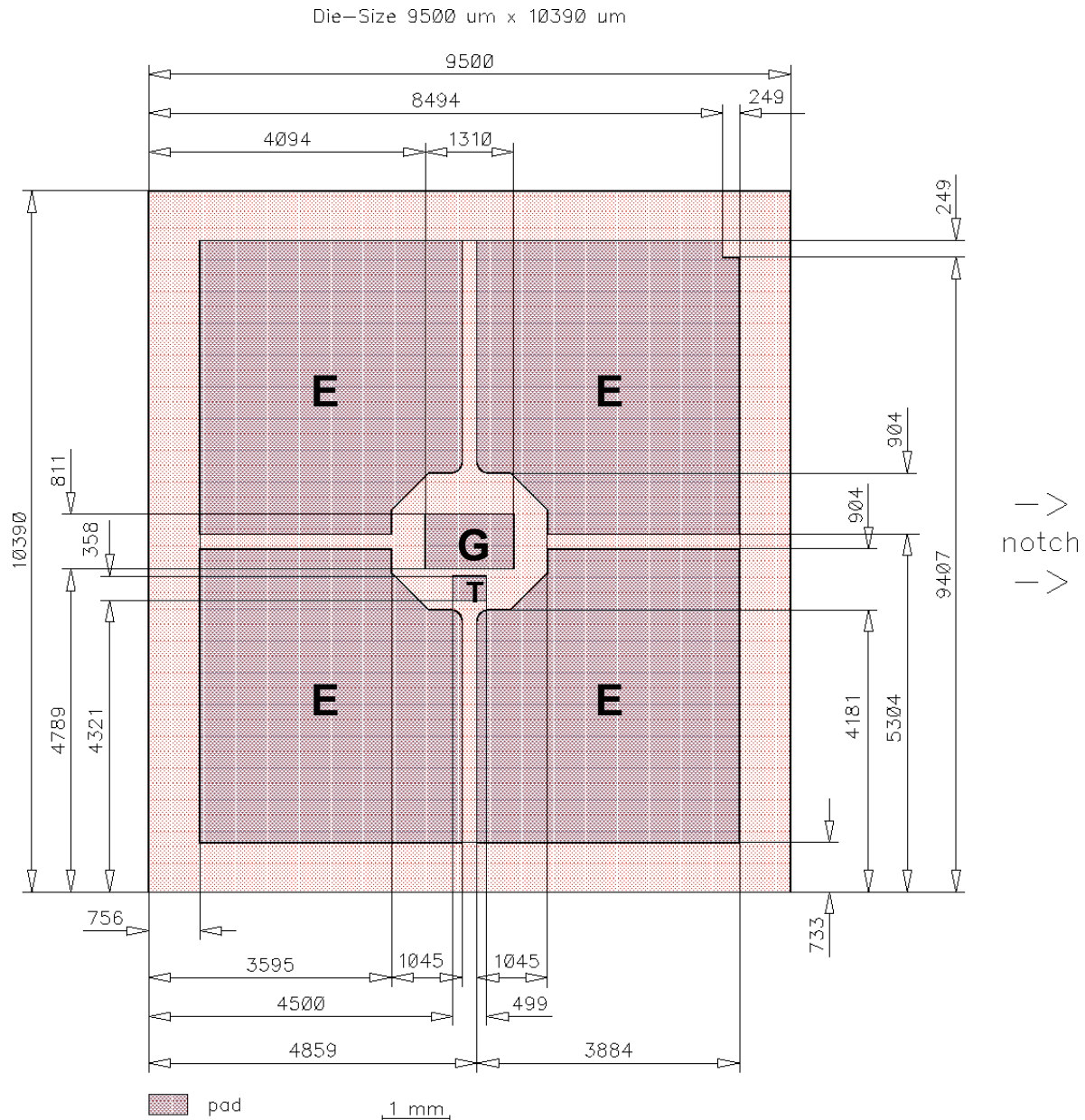
Switching characteristics and thermal properties are depending strongly on module design and mounting technology and can therefore not be specified for a bare die.

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|                     |                 |          |
|---------------------|-----------------|----------|
| Application example | FP100R12KT4_B11 | Rev. 3.0 |
|---------------------|-----------------|----------|

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## Chip Drawing



**E** = Emitter  
**G** = Gate  
**T** = Test pad do not contact



# IGC99T120T8RL

## Bare Die Product Specifics

Test coverage at wafer level cannot cover all application conditions. Therefore it is recommended to test all characteristics which are relevant for the application at package level, including RBSOA and SCSOA.

## Description

AQL 0.65 for visual inspection according to failure catalogue

Electrostatic Discharge Sensitive Device according to MIL-STD 883

## Revision History

| Revision | Subjects (major changes since last revision) | Date       |
|----------|--|------------|
| 2.0      | Final data sheet                             | 18.02.2015 |
| 2.1      | Update disclaimer                            | 20.08.2015 |
|          |  |            |

## Relevant Application Notes

|  |
|--|
|  |
|--|



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